

Notice of References Cited

Application/Control No.

10/594,071

Applicant(s)/Patent Under
Reexamination
TOBISAKA ET AL.

Examiner

QUEENIE DEGHAN

Art Unit

1791

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0016216	01-2005	Kim et al.	065/384
*	B	US-2002/0148257	10-2002	Shimizu et al.	65/377
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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